Se	arch No	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/616,638	CASTAGNA ET AL.
Examiner	Art Unit
Elias Desta	2857

	SEARCHED		
Class	Subclass	Date	Examiner
702	6,2,11,12, 17,18	5/3/2005	E.D
73	594,152.*	5/3/2005	E.D
367	911,75,74	5/3/2005	E.D
346	33C	5/3/2005	E.D
340	856.4	5/3/2005	E.D
299	14	5/3/2005	E.D
181	108,106	5/3/2005	E.D
175	50,40,1	5/3/2005	E.D
375	240.19	5/3/2005	E.D

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
702	11,14,17	5/3/2005	E.D
73	594,152.*	5/3/2005	E.D
367	911,75,74	5/3/2005	E.D
299/14;18	340/856.4; 31/108,106; 1;375/240.*	5/3/2005	E.D

SEARCH NOT (INCLUDING SEARCH)		)
	DATE	EXMR
Method of search: EAST, PLUS, YAHOO, GOOGLE, IEEE Explore and CRC	5/3/2005	E.D
Consulted: Stamber, Eric, 101 Panel; Ian Lobo, class 367, au: 3662	5/3/2005	E.D
Key word or text searches: see attachment.	5/3/2005	E.D